

Form PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

LIST OF ART CITED BY APPLICANT

ATTY. DOCKET NO. H0001831(4016)

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APPLICANT	

(Use several sheets if necessary) Honeywell International Inc. GROUP FILING DATE 1742 U.S. PATENT DOCUMENTS Date Class \*Examiner Document Name Subclass Filing Date Number If Appropriate Initial 4,891,066 1/2/90 Shimotori et al. AA AB 4,793,854 10/27/92 Shimotori et al. 4/20/93 AC 5,204,057 Ishigami et al. Re. 34,598 5/3/94 Shimotori et al. AD ΑE 5,584,906 12/17/96 Ishigami et al. ΑF 6,024,847 2/15/00 Rosenberg et al. AG ΑH Αl ΑJ AK AL FOREIGN PATENT DOCUMENTS Class Date Subclass Translation Document Country Number No AM AN ΑO ΑP AQ OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.) "Electrochemical Reduction of Tantalum in Molten NaCl-K, TaF,": Transactions of Nfsoc; Vol. 2, No. 3; Li, Guoxun; Barhoun, A.; ΑR Lantelme, F.; Chemla, M.; pp. 64-68 AS **EXAMINER** DATE CONSIDERED \*EXAMINER: Initial if to erence considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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## U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. H0001831(4016)

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